Search Notes		

•	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/533,267	HAGIWARA ET AL.	
	Examiner	Art Unit	Ī
	Anthony Weier	1761	

SEARCHED			
Class	Subclass	Date	Examiner
426	634, 459, 285	3/17/2006	AW

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
inventor search	3/17/2006	AW	